

ZXMP3F37DN8 30V SO8 Dual P-channel enhancement mode MOSFET

Summary

V _{(BR)DSS} (V)	R _{DS(on)} (Ω)	I _D (A)
-30	0.025 @ V _{GS} =-10V	-8.3
	0.041 @ V _{GS} =-4.5V	



This new generation Trench MOSFET from Zetex has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Features

- Low on-resistance
- · Fast switching speed
- Low gate drive
- Dual SO8 package

Applications

- DC-DC Converters
- Power management functions
- Disconnect switches
- Motor control

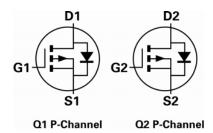
Ordering information

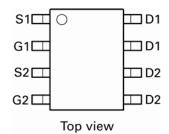
Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMP3F37DN8TA	7	12	500

Device marking

ZXMP 3F37D







Absolute maximum ratings

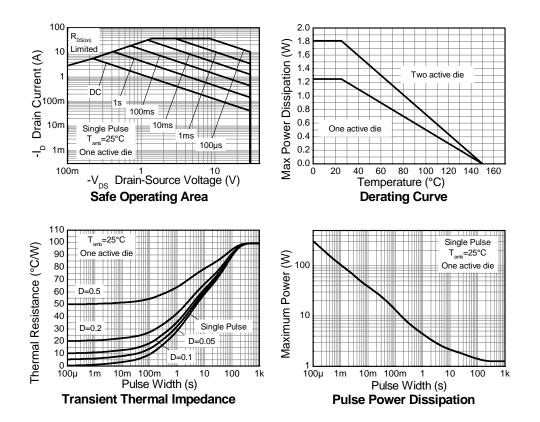
Parameter	Symbol	Limit	Unit
Drain-Source voltage	V_{DSS}	-30	V
Gate-Source voltage	V _{GS}	±20	V
Continuous Drain current @ V_{GS} = -10V; T_A =25°C (b)(d)	I _D	-7.3 -5.9	V
@ V_{GS} = -10V; T_A =70°C $\stackrel{\text{(b)(d)}}{}$ @ V_{GS} = -10V; T_A =25°C $\stackrel{\text{(f)}}{}$		-5.7	
@ V _{GS} = -10V; T _L =25°C ^(f)		-8.3	
Pulsed Drain current ^(c)	I _{DM}	-36	Α
Continuous Source current (Body diode) (b)	I _S	-3.5	Α
Pulsed Source current (Body diode) (c)	I _{SM}	-36	А
Power dissipation at T _A =25°C (a)(d) Linear derating factor	P _D	1.25 10	W mW/°C
Power dissipation at T _A =25°C (a)(e) Linear derating factor	P _D	1.8 14	W mW/°C
Power dissipation at T _L =25°C (b)(d) Linear derating factor	P _D	2.1 17	W mW/°C
Power dissipation at T _L =25°C (a)(f) Linear derating factor	P _D	2.7 21.5	W mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Value	Unit
Junction to ambient (a)(d)	$R_{ heta JA}$	100	°C/W
Junction to ambient (b)(e)	$R_{ heta JA}$	70	°C/W
Junction to ambient (b)(d)	$R_{ heta JA}$	60	°C/W
Junction to lead ^{(a)(f)}	$R_{ hetaJL}$	46.42	°C/W

- (a) For a dual device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (b) For a dual device surface mounted on FR4 PCB measured at t ≤ 10 sec.
 (c) Repetitive rating on 25mm x 25mm FR4 PCB, D=0.02, pulse width 300us pulse width limited by maximum junction
- (d) For a dual device with one active die.
- (e) For a dual device with 2 active die running at equal power.
 (f) Thermal resistance from junction to solder-point (at the end of the drain lead).

Thermal characteristics



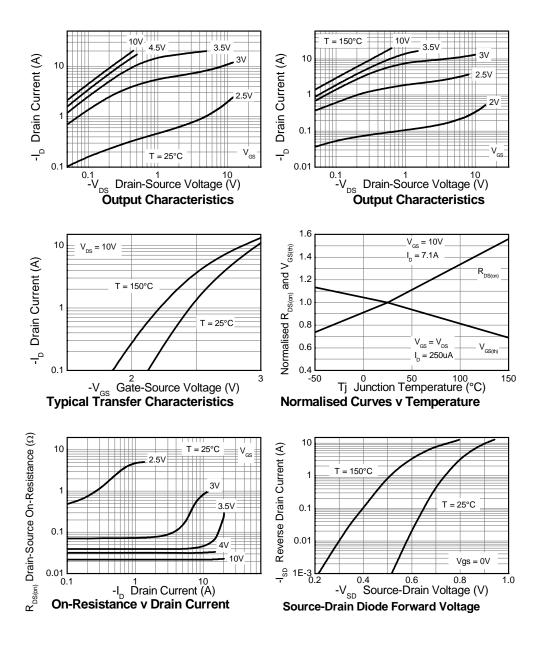
Electrical characteristics (at T_{amb} = 25°C unless otherwise stated) Q1 and Q2

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Static						_
Drain-Source breakdown voltage	V _{(BR)DSS}	-30			V	$I_D = -250 \mu A, V_{GS} = 0V$
Zero Gate voltage Drain current	I _{DSS}			-1.0	μA	V _{DS} =-YV, V _{GS} =0V
Gate-Body leakage	I _{GSS}			100	nA	$V_{GS}=\pm20V, V_{DS}=0V$
Gate-Source threshold voltage	V _{GS(th)}	-1.3		-2.5	V	$I_D=$ -250 μ A, $V_{DS}=V_{GS}$
Static Drain-Source on-state resistance (*)	R _{DS(on)}			0.025 0.041	Ω	V_{GS} = -10V, I_{D} = -7.1A V_{GS} = -4.5V, I_{D} = -5.5A
Forward Transconductance (*) (†)	g _{fs}		18.6		S	V _{DS} = -15V, I _D = -7.1A
Dynamic (†)						
Input capacitance	C _{iss}		1678		pF	
Output capacitance	Coss		303		pF	V _{DS} = -15V, V _{GS} =0V
Reverse transfer capacitance	C _{rss}		178		pF	f=1MHz
Switching (‡) (†)						
Turn-on-delay time	t _{d(on)}		3.5		ns	
Rise time	t _r		4.9		ns	V _{DD} = -15V, V _{GS} = -10V
Turn-off delay time	t _{d(off)}		44		ns	I _D = -1A
Fall time	t _f		28		ns	$R_G \cong 6.0\Omega$,
Gate charge						_
Total Gate charge	Q_g		31.6		nC	
Gate-Source charge	Q _{gs}		4.3		nC	V _{DS} = -15V, V _{GS} = -10V
Gate-Drain charge	Q _{gd}		6.2		nC	I _D = -7.1A
Source-Drain diode			•	•	•	
Diode forward voltage (*)	V _{SD}		-0.80	-1.2	V	I _S = -1.7A,V _{GS} =0V
Reverse recovery time (‡)	t _{rr}		16.2		ns	- I _S = -2.2A,di/dt=100A/μs
Reverse recovery charge ^(‡)	Q _{rr}		10		nC	152.27,ui/ul=1007/µS

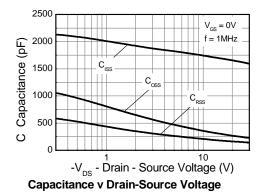
^(*) Measured under pulsed conditions. Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.

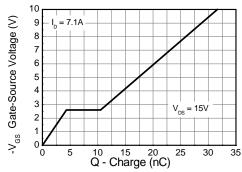
^(†)Switching characteristics are independent of operating junction temperature. (‡)For design aid only, not subject to production testing

Typical characteristics



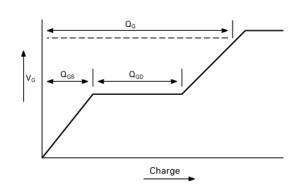
Typical characteristics

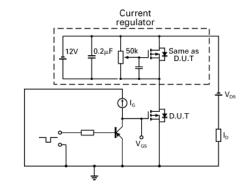




Gate-Source Voltage v Gate Charge

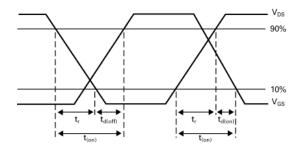
Test circuits

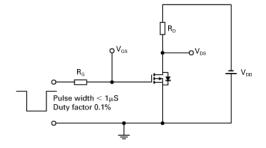




Basic gate charge waveform

Gate charge test circuit

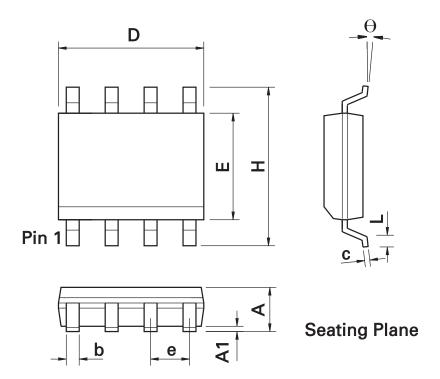




Switching time waveforms

Switching time test circuit

Package outline SO8



SO8 Package Information

DIM	Inc	hes	Millin	neters	DIM	DIM Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	U	0°	8°	0°	8°
Е	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	1	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

ZXMP3F37DN8

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- for use provided in the labeling can be reasonably expected to result in significant injury to the user.

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